International
IOR Rectifier

Data Sheet No. PD-6.031C

IR2117

SINGLE CHANNEL DRIVER

Features

- Floating channel designed for bootstrap operation
  Fully operational to +600V
  Tolerant to negative transient voltage
  dV/dt immune
- Gate drive supply range from 10 to 20V
- Undervoltage lockout
- CMOS Schmitt-triggered inputs with pull-down
- Output in phase with input

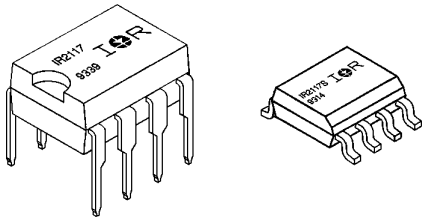
Product Summary

V_{OFFSET}	600V max.
I_O+/-	200 mA / 420 mA
V_{OUT}	10 - 20V
$t_{on/off}$ (typ.)	125 & 105 ns

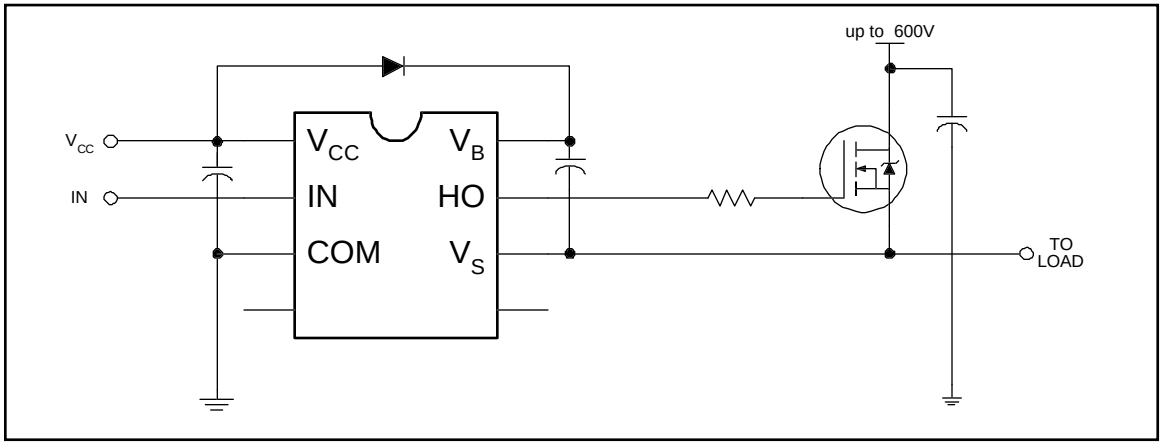
Description

The IR2117 is a high voltage, high speed power MOSFET and IGBT driver. Proprietary HVIC and latch immune CMOS technologies enable ruggedized monolithic construction. The logic input is compatible with standard CMOS outputs. The output driver features a high pulse current buffer stage designed for minimum cross-conduction. The floating channel can be used to drive an N-channel power MOSFET or IGBT in the high or low side configuration which operates up to 600 volts.

Packages



Typical Connection



Absolute Maximum Ratings

Absolute Maximum Ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to COM. The Thermal Resistance and Power Dissipation ratings are measured under board mounted and still air conditions. Additional information is shown in Figures 5 through 8.

Parameter		Value		
Symbol	Definition	Min.	Max.	Units
V_B	High Side Floating Supply Voltage	-0.3	625	V
V_S	High Side Floating Supply Offset Voltage	V_B - 25	V_B + 0.3	
V_{HO}	High Side Floating Output Voltage	V_S - 0.3	V_B + 0.3	
V_{CC}	Logic Supply Voltage	-0.3	25	
V_{IN}	Logic Input Voltage	-0.3	V_{CC} + 0.3	
dV_S/dt	Allowable Offset Supply Voltage Transient (Figure 2)	—	50	V/ns
P_D	Package Power Dissipation @ $T_A \leq +25°C$ (8 Lead DIP)	—	1.0	W
	(8 Lead SOIC)	—	0.625	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (8 Lead DIP)	—	125	°C/W
	(8 Lead SOIC)	—	200	
T_J	Junction Temperature	—	150	°C
T_S	Storage Temperature	-55	150	
T_L	Lead Temperature (Soldering, 10 seconds)	—	300	

Recommended Operating Conditions

The Input/Output logic timing diagram is shown in Figure 1. For proper operation the device should be used within the recommended conditions. The V_S offset rating is tested with all supplies biased at 15V differential.

Parameter		Value		
Symbol	Definition	Min.	Max.	Units
V_B	High Side Floating Supply Absolute Voltage	V_S + 10	V_S + 20	V
V_S	High Side Floating Supply Offset Voltage	Note 1	600	
V_{HO}	High Side Floating Output Voltage	V_S	V_B	
V_{CC}	Logic Supply Voltage	10	20	
V_{IN}	Logic Input Voltage	0	V_{CC}	
T_A	Ambient Temperature	-40	125	°C

Note 1: Logic operational for V_S of -5 to +600V. Logic state held for V_S of -5V to $-V_{BS}$.

Dynamic Electrical Characteristics

V_{BIAS} (V_{CC}, V_{BS}) = 15V, C_L = 1000 pF and T_A = 25°C unless otherwise specified. The dynamic electrical characteristics are measured using the test circuit shown in Figure 3.

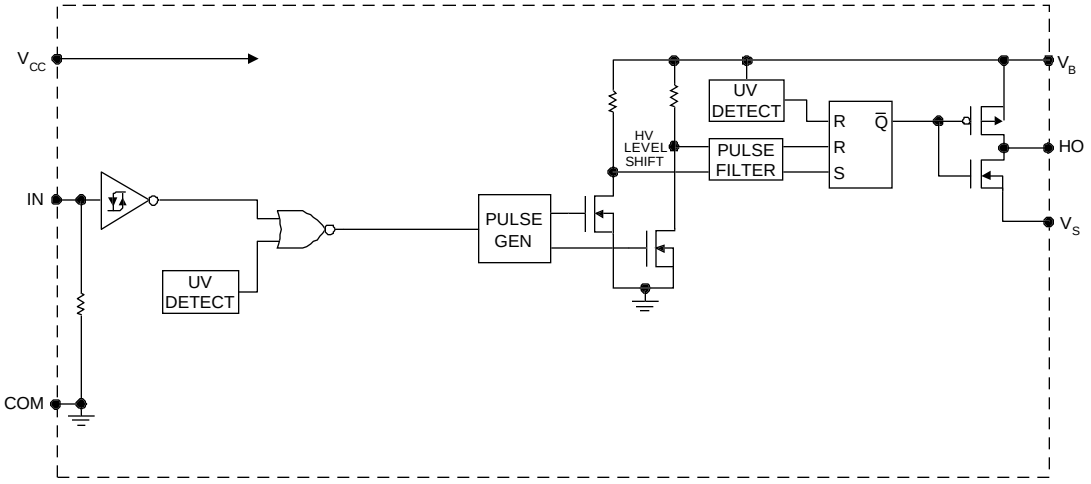
Parameter		Value				
Symbol	Definition	Min.	Typ.	Max.	Units	Test Conditions
t_{on}	Turn-On Propagation Delay	—	125	200	ns	V_S = 0V
t_{off}	Turn-Off Propagation Delay	—	105	180		V_S = 600V
t_r	Turn-On Rise Time	—	80	130		
t_f	Turn-Off Fall Time	—	40	65		

Static Electrical Characteristics

V_{BIAS} (V_{CC}, V_{BS}) = 15V and T_A = 25°C unless otherwise specified. The V_{IN}, V_{TH} and I_{IN} parameters are referenced to COM. The V_O and I_O parameters are referenced to COM and are applicable to the respective output leads: HO or LO.

Parameter		Value				
Symbol	Definition	Min.	Typ.	Max.	Units	Test Conditions
V_{IH}	Logic "1" Input Voltage	6.4	—	—	V	V_{CC} = 10V
		9.5	—	—		V_{CC} = 15V
		12.6	—	—		V_{CC} = 20V
V_{IL}	Logic "0" Input Voltage	—	—	3.8		V_{CC} = 10V
		—	—	6.0		V_{CC} = 15V
		—	—	8.3		V_{CC} = 20V
V_{OH}	High Level Output Voltage, V_{BIAS} - V_O	—	—	100	mV	I_O = 0A
V_{OL}	Low Level Output Voltage, V_O	—	—	100		I_O = 0A
I_{LK}	Offset Supply Leakage Current	—	—	50	µA	V_B = V_S = 600V
I_{QBS}	Quiescent V_{BS} Supply Current	—	50	240		V_{IN} = 0V or V_{CC}
I_{QCC}	Quiescent V_{CC} Supply Current	—	70	340		V_{IN} = 0V or V_{CC}
I_{IN+}	Logic "1" Input Bias Current	—	20	40		V_{IN} = V_{CC}
I_{IN-}	Logic "0" Input Bias Current	—	—	1.0		V_{IN} = 0V
V_{BSUV+}	V_{BS} Supply Undervoltage Positive Going Threshold	7.6	8.6	9.6	V	
V_{BSUV-}	V_{BS} Supply Undervoltage Negative Going Threshold	7.2	8.2	9.2		
V_{CCUV+}	V_{CC} Supply Undervoltage Positive Going Threshold	7.6	8.6	9.6		
V_{CCUV-}	V_{CC} Supply Undervoltage Negative Going Threshold	7.2	8.2	9.2		
I_{O+}	Output High Short Circuit Pulsed Current	200	250	—	mA	V_O = 0V, V_{IN} = V_{CC} PW ≤ 10 µs
I_{O-}	Output Low Short Circuit Pulsed Current	420	500	—		V_O = 15V, V_{IN} = 0V PW ≤ 10 µs

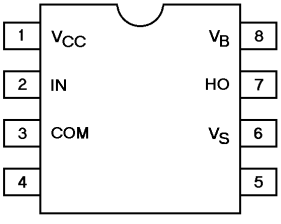
Functional Block Diagram



Lead Definitions

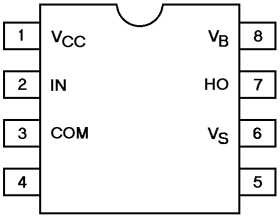
Lead Symbol	Description
V_{CC}	Logic and gate drive supply
IN	Logic input for gate driver output (HO), in phase with HO
COM	Logic ground
V_B	High side floating supply
HO	High side gate drive output
V_S	High side floating supply return

Lead Assignments



8 Lead DIP

IR2117

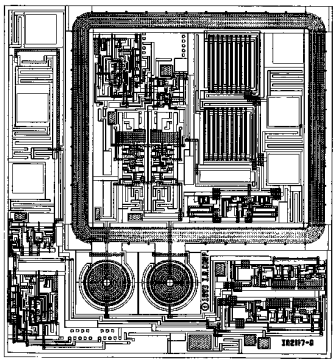


S0-8

IR2117S

Part Number

Device Information

Process & Design Rule			HVDCMOS 4.0 µm
Transistor Count			114
Die Size			70 X 77 X 26 (mil)
Die Outline			
Thickness of Gate Oxide			800Å
Connections		Material	Poly Silicon
	First Layer	Width	4 µm
		Spacing	6 µm
		Thickness	5000Å
		Material	Al - Si (Si: 1.0% ±0.1%)
	Second Layer	Width	6 µm
		Spacing	9 µm
		Thickness	20,000Å
Contact Hole Dimension			8 µm X 8 µm
Insulation Layer		Material	PSG (SiO_2)
		Thickness	1.5 µm
Passivation		Material	PSG (SiO_2)
		Thickness	1.5 µm
Method of Saw			Full Cut
Method of Die Bond			Ablebond 84 - 1
Wire Bond		Method	Thermo Sonic
		Material	Au (1.0 mil / 1.3 mil)
Leadframe		Material	Cu
		Die Area	Ag
		Lead Plating	Pb : Sn (37 : 63)
Package		Types	8 Lead PDIP / SO-8
		Materials	EME6300 / MP150 / MP190
Remarks:			

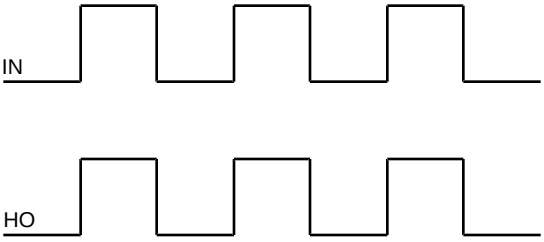


Figure 1. Input/Output Timing Diagram

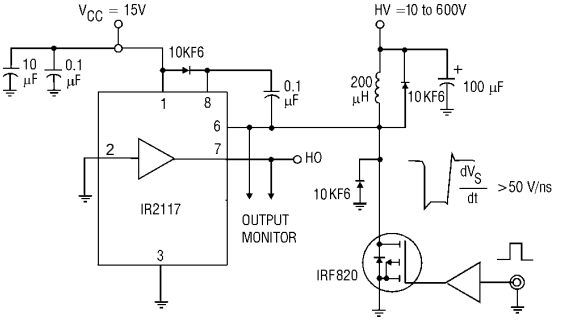


Figure 2. Floating Supply Voltage Transient Test Circuit

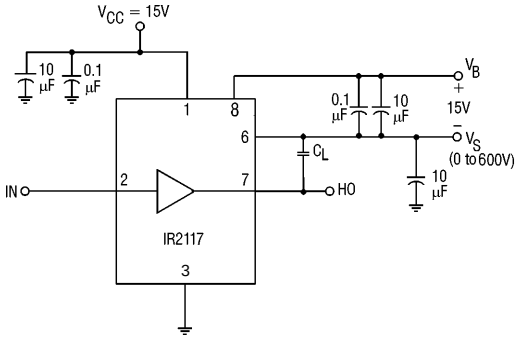


Figure 3. Switching Time Test Circuit

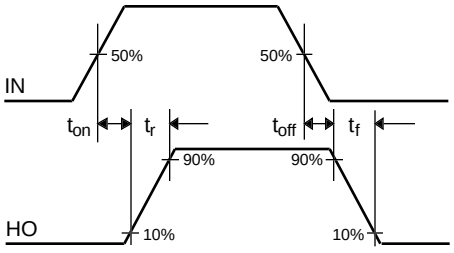


Figure 4. Switching Time Waveform Definition

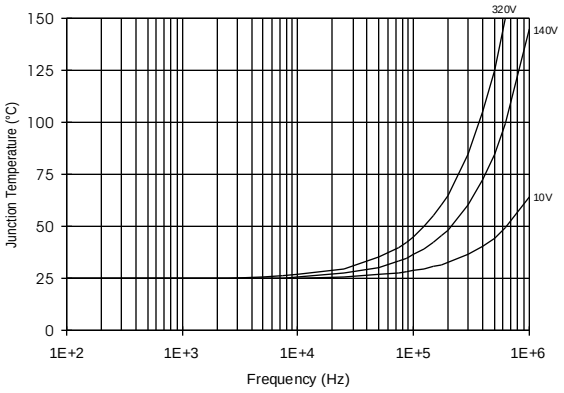


Figure 5. IR2117 T_J vs. Frequency (IRFBC20)
R_{GATE} = 33Ω, V_{CC} = 15V

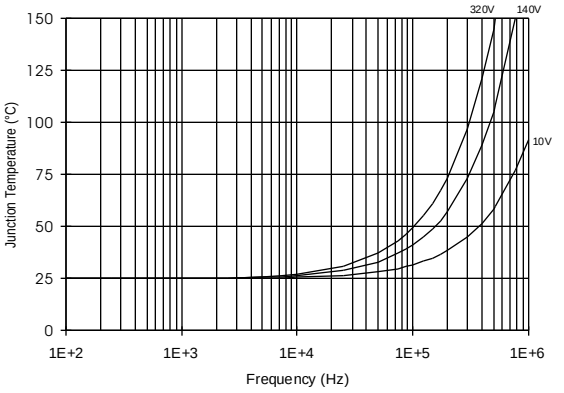


Figure 6. IR2117 T_J vs. Frequency (IRFBC30)
R_{GATE} = 22Ω, V_{CC} = 15V

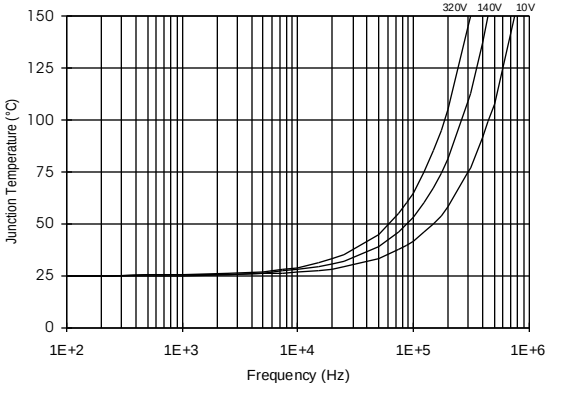


Figure 7. IR2117 T_J vs. Frequency (IRFBC40)
R_{GATE} = 15Ω, V_{CC} = 15V

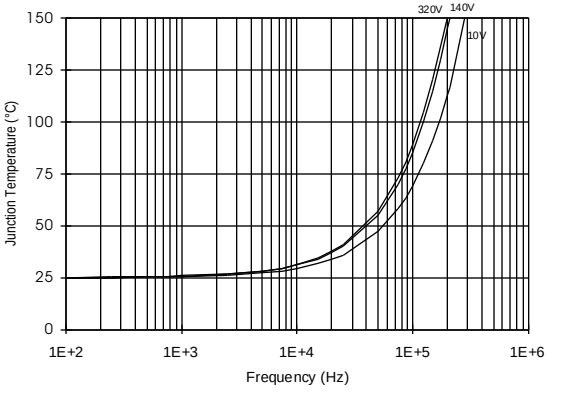


Figure 8. IR2117 T_J vs. Frequency (IRFPE50)
R_{GATE} = 10Ω, V_{CC} = 15V